

Search Notes

Application/Control No.

10/727,262

Examiner

Khanh V. Nguyen

Applicant(s)/Patent under
Reexamination

GLASS ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	285	6/28/2005	NKV
330	296	6/28/2005	NKV
330	311	6/28/2005	NKV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
See Search History Printout		5/8/2006	NKV

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	5/8/2006	NKV